Application/Control No. Applicant(s)/Patent Under Reexamination 10/797,544 CHEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2873 Tuyen Q. Tra **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY X US-6,821,799 11-2004 Steckl et al. 438/22 Α US-В US-С US-D US-Ε US-F US-G US-Н USı US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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